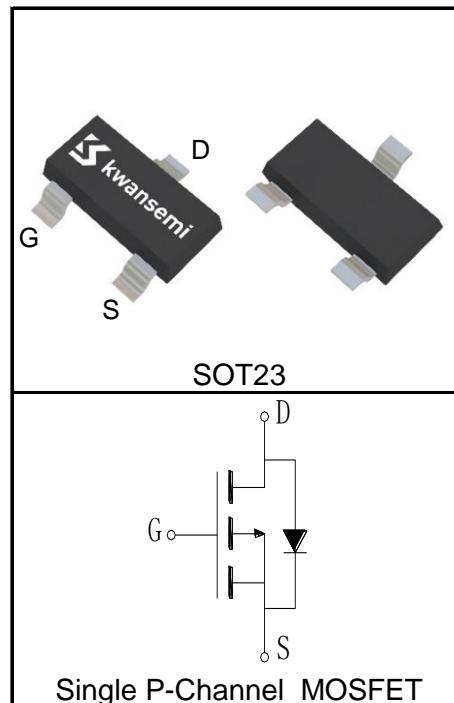


Features

- -16V/-5.9A,
 $R_{DS(ON)} = 17\text{m}\Omega(\text{Typ.}) @ V_{GS} = -4.5\text{V}$
- $R_{DS(ON)} = 22\text{m}\Omega(\text{Typ.}) @ V_{GS} = -2.5\text{V}$
- $R_{DS(ON)} = 32\text{m}\Omega(\text{Typ.}) @ V_{GS} = -1.8\text{V}$
- Super High Dense Cell Design
- Reliable and Rugged

Pin Description



Applications

- Load Switch



Halogen-Free

Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit
Common Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)			
V_{DSS}	Drain-Source Voltage	-16	V
V_{GSS}	Gate-Source Voltage	± 12	
T_{Jmax}	Maximum Junction Temperature	150	$^\circ\text{C}$
T_J, T_{STG}	Operating and Storage Temperature Range	-55 to 150	$^\circ\text{C}$
I_S	Diode Continuous Forward Current	$T_A = 25^\circ\text{C}$	-1.2
Mounted on Large Heat Sink			
$I_{DP}^{①}$	Pulse Drain Current	$T_A = 25^\circ\text{C}$	-23
$I_D^{②}$	Continuous Drain Current($V_{GS} = -4.5\text{V}$)	$T_A = 25^\circ\text{C}$	-5.9
		$T_A = 70^\circ\text{C}$	-4.7
P_D	Maximum Power Dissipation	$T_A = 25^\circ\text{C}$	1
		$T_A = 70^\circ\text{C}$	0.64
$R_{\theta JL}$	Thermal Resistance-Junction to Lead	80	$^\circ\text{C}/\text{W}$
$R_{\theta JA}^{③}$	Thermal Resistance-Junction to Ambient	125	$^\circ\text{C}/\text{W}$
Drain-Source Avalanche Ratings			
$E_{AS}^{④}$	Avalanche Energy, Single Pulsed	20	mJ

Electrical Characteristics ($T_A=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Condition	KS0335AA			Unit
			Min.	Typ.	Max.	
Static Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=-250\mu\text{A}$	-16			V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-16\text{V}, V_{\text{GS}}=0\text{V}$			-1	μA
		$T_J=125^\circ\text{C}$			-30	
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=-250\mu\text{A}$	-0.4	-0.7	-1	V
I_{GSS}	Gate Leakage Current	$V_{\text{GS}}=\pm 12\text{V}, V_{\text{DS}}=0\text{V}$			± 100	nA
$R_{\text{DS}(\text{ON})}^{(5)}$	Drain-Source On-state Resistance	$V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-4\text{A}$		17	21	mΩ
		$V_{\text{GS}}=-2.5\text{V}, I_{\text{DS}}=-3\text{A}$		22	30	mΩ
		$V_{\text{GS}}=-1.8\text{V}, I_{\text{DS}}=-2\text{A}$		32	45	mΩ
Diode Characteristics						
$V_{\text{SD}}^{(5)}$	Diode Forward Voltage	$I_{\text{SD}}=-4\text{A}, V_{\text{GS}}=0\text{V}$		-0.8	-1.2	V
t_{rr}	Reverse Recovery Time	$I_{\text{SD}}=-4\text{A}, dI_{\text{SD}}/dt=-100\text{A}/\mu\text{s}$		22		ns
Q_{rr}	Reverse Recovery Charge			16		nC
Dynamic Characteristics ⁽⁶⁾						
R_G	Gate Resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V}, F=1\text{MHz}$		13		Ω
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=-8\text{V}, \text{Frequency}=1.0\text{MHz}$		1255		pF
C_{oss}	Output Capacitance			220		
C_{rss}	Reverse Transfer Capacitance			180		
$t_{\text{d}(\text{ON})}$	Turn-on Delay Time	$V_{\text{DD}}=-8\text{V}, I_{\text{DS}}=-4\text{A}, V_{\text{GEN}}=-4.5\text{V}, R_G=6\Omega$		17		ns
t_r	Turn-on Rise Time			13		
$t_{\text{d}(\text{OFF})}$	Turn-off Delay Time			64		
t_f	Turn-off Fall Time			28		
Gate Charge Characteristics ⁽⁶⁾						
Q_g	Total Gate Charge	$V_{\text{DS}}=-8\text{V}, V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-4\text{A}$		9.8		nC
Q_{gs}	Gate-Source Charge			1.9		
Q_{gd}	Gate-Drain Charge			3		

Notes: (1)Pulse width limited by safe operating area.

(2)Calculated continuous current based on maximum allowable junction temperature.

(3)When mounted on 1 inch square copper board, $t \leq 10\text{sec}$. The value in any given application depends on the user's specific board design.

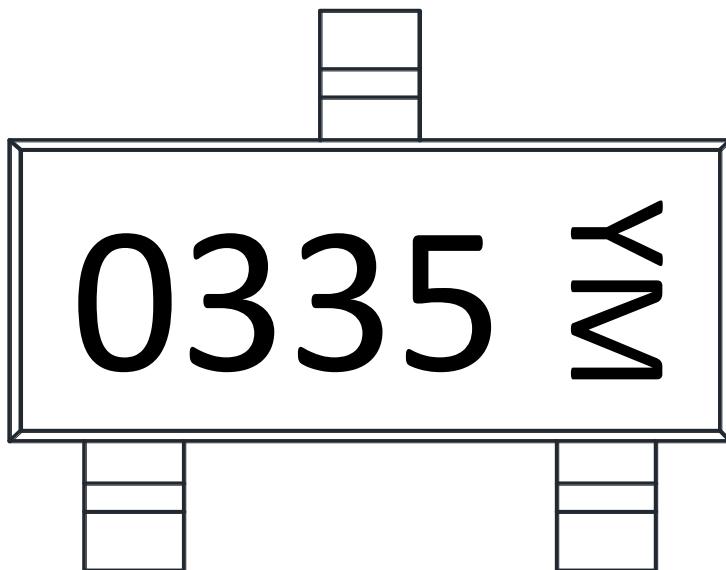
(4)Limited by $T_{J\text{max}}$, Starting $T_J = 25^\circ\text{C}$, $I_{AS\text{max}} = -9\text{A}$, $L = 0.5\text{mH}$, $V_{\text{DD}}=-10\text{V}$, $R_G = 25\Omega$, $V_{\text{GS}} = -4.5\text{V}$.Part not recommended for use above this value.

(5)Pulse test;Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

(6)Guaranteed by design, not subject to production testing.

Ordering and Marking Information

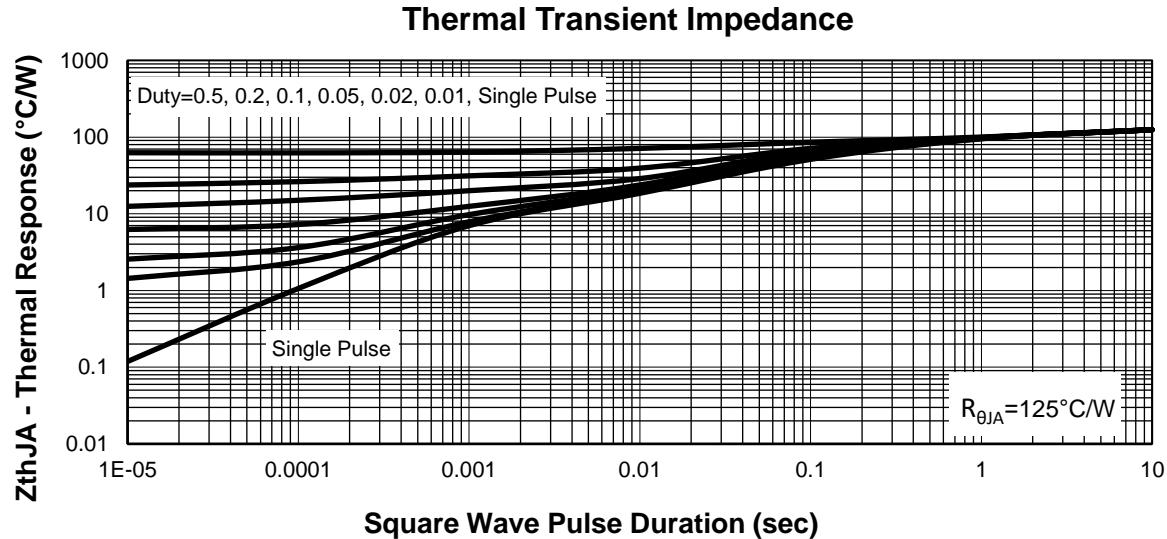
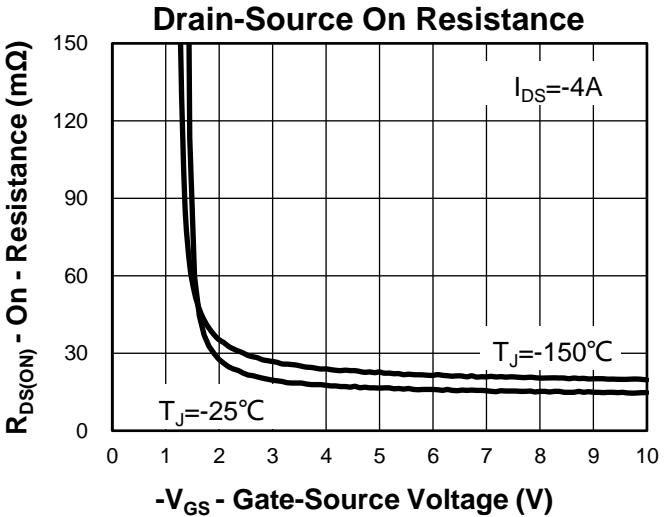
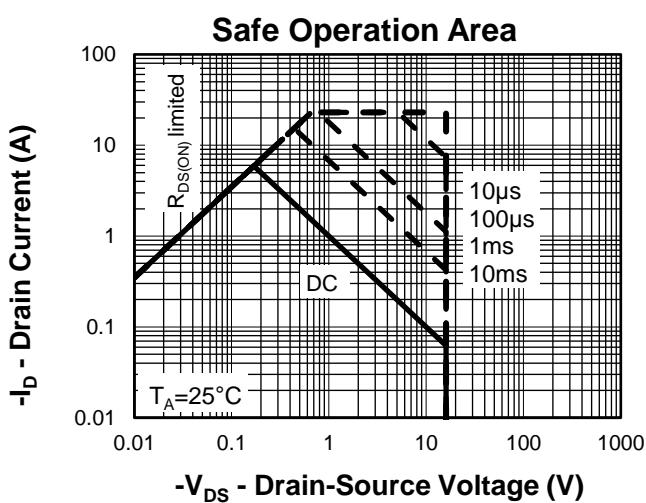
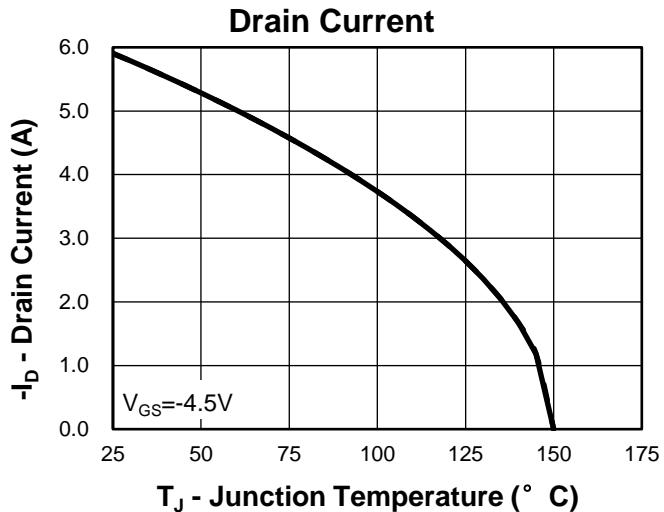
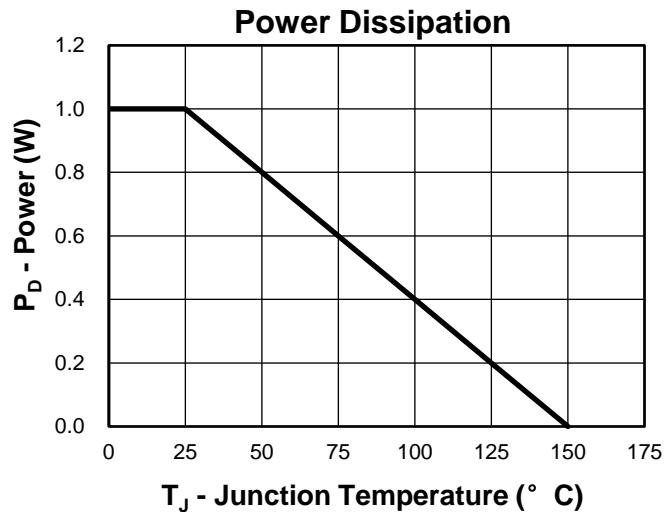
Device	Package	Packaging	Quantity	Reel Size	Tape width
KS0335AA	SOT23	Tape&Reel	3000	7"	8mm



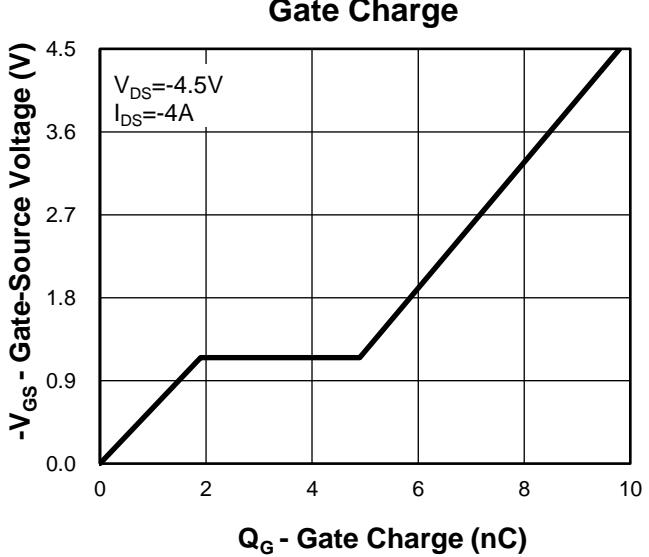
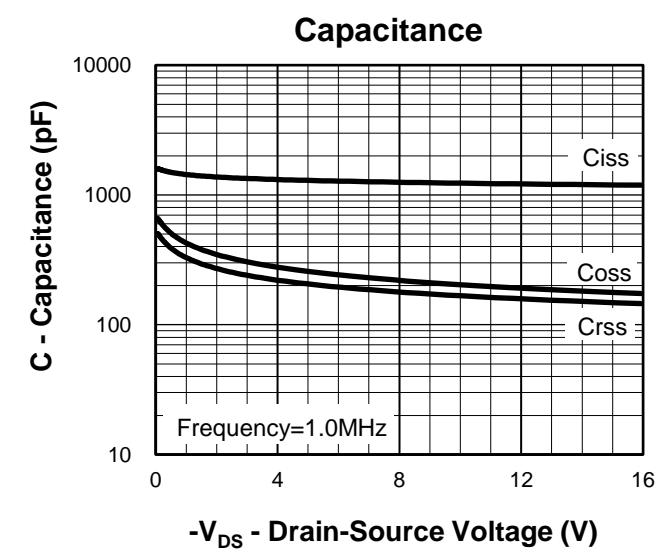
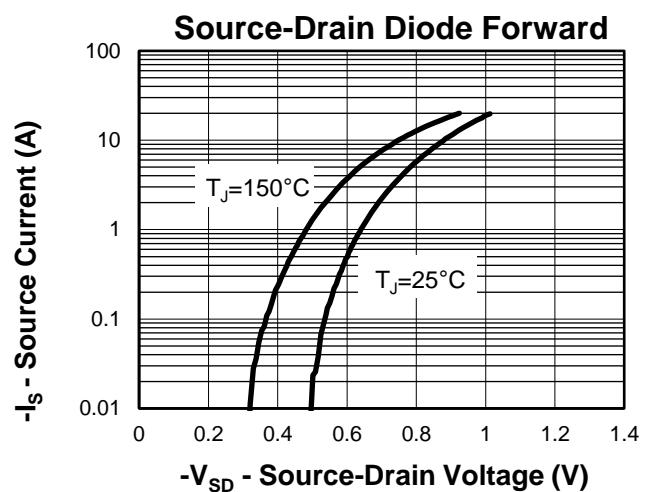
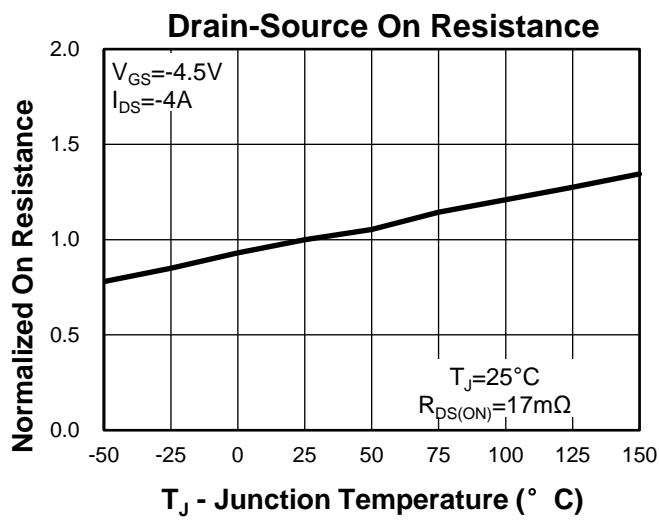
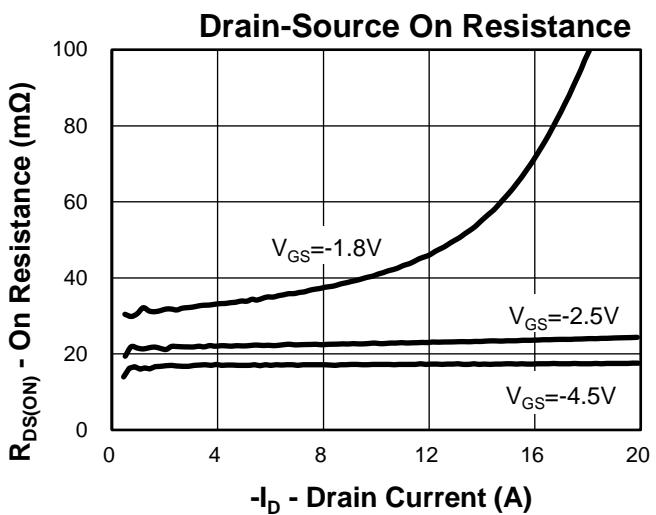
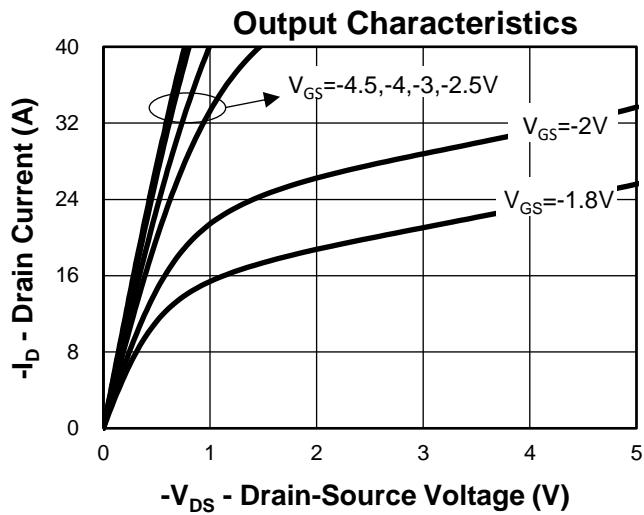
Y =Year,2017-A,2018-B,etc.

M =Month,Jan-1,Feb-2,...,Sep-9,Oct-A,Nov-B,Dec-C.

Typical Characteristics

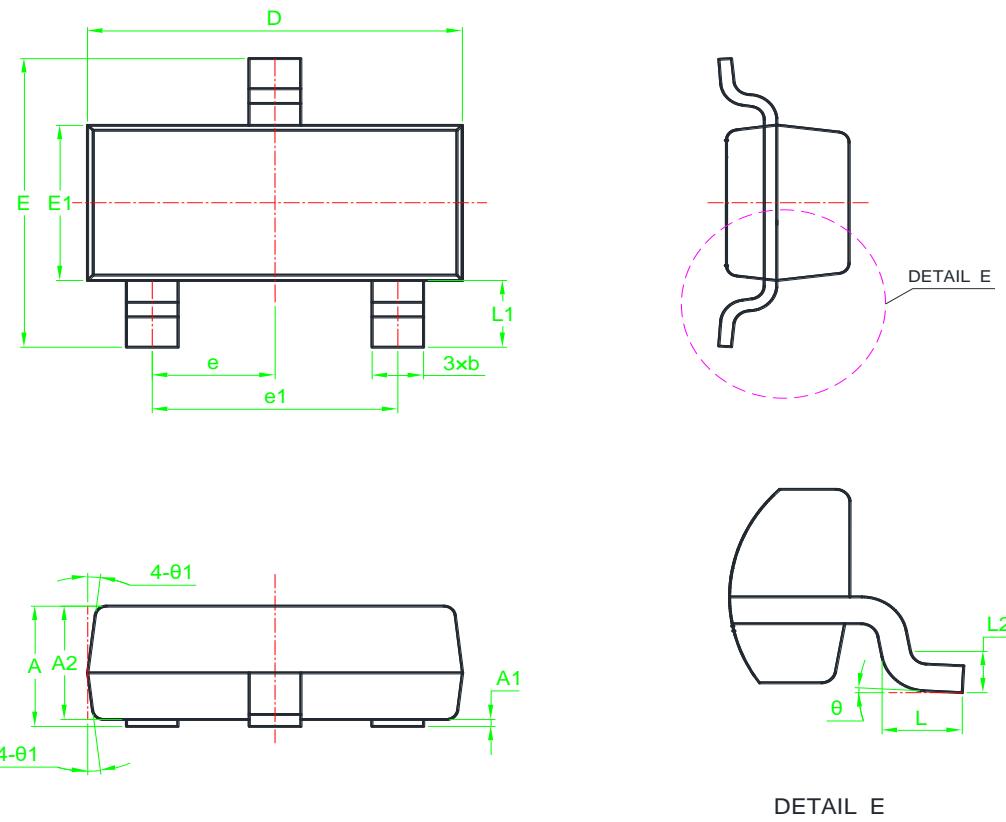


Typical Characteristics



Package Information

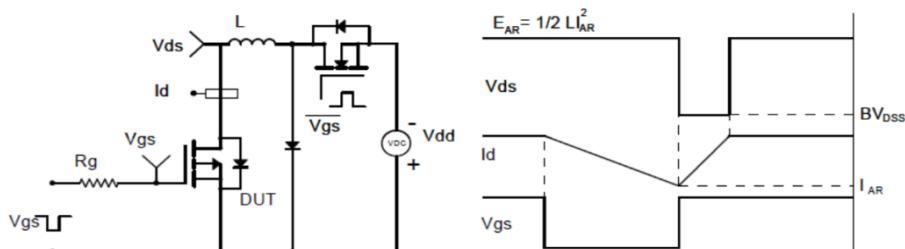
SOT23



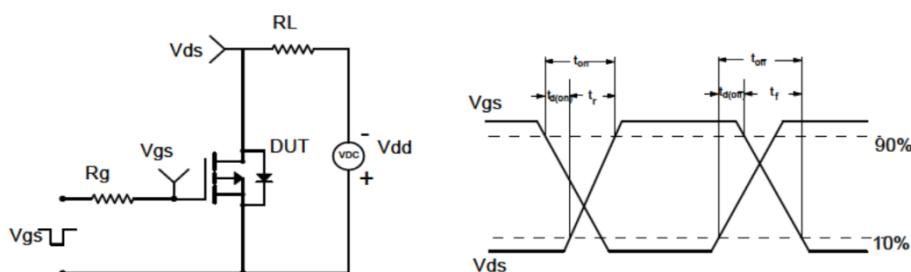
SYMBOL	MM			INCH			SYMBOL	MM			INCH		
	MIN	NOM	MAX	MIN	NOM	MAX		MIN	NOM	MAX	MIN	NOM	MAX
A	0.90	*	1.12	0.035	*	0.044	e	0.95BSC			0.037BSC		
A1	0.01	*	0.10	0.000	*	0.004	e1	1.90BSC			0.075BSC		
A2	0.80	0.90	1.02	0.031	0.035	0.040	L	0.30	0.40	0.50	0.012	0.016	0.020
b	0.30	0.40	0.50	0.012	0.016	0.020	L1	0.54REF			0.021REF		
D	2.80	2.90	3.00	0.110	0.114	0.118	L2	0.254BSC			0.010BSC		
E	2.25	2.40	2.55	0.089	0.094	0.100	θ	0°	*	8°	0°	*	8°
E1	1.20	1.30	1.40	0.047	0.051	0.055	θ1	0°	*	10°	0°	*	10°

Note: Dimensions do not include burrs and mold flash.

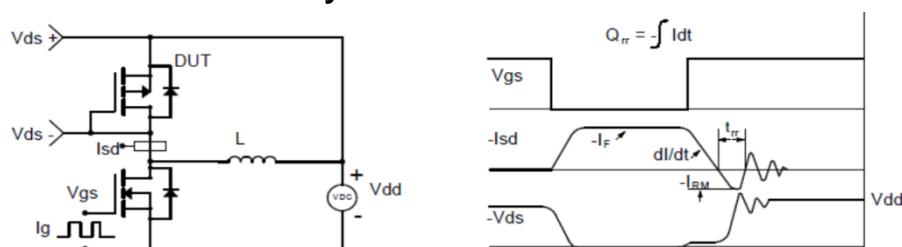
Avalanche Test Circuit and Waveforms



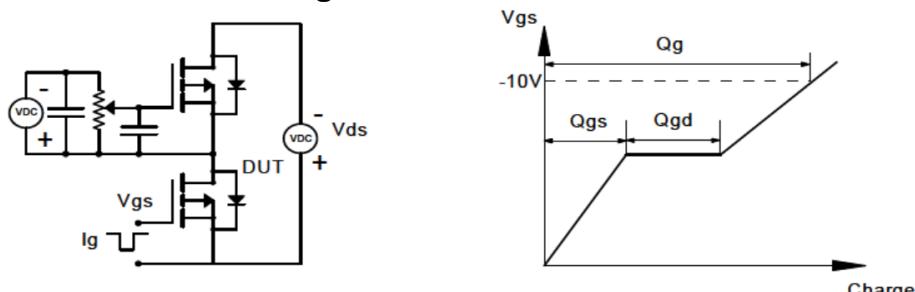
Switching Time Test Circuit and Waveforms



Diode Recovery Test Circuit and Waveforms



Gate Charge Test Circuit and Waveform



Customer Service

Kwansemi Semiconductor Co.,Ltd

Email:Sales@kwansemi.com

Web:www.kwansemi.com

DISCLAIMER:

Kwansemi reserves the right to change the specifications and circuitry without notice at any time. The Products are not designed for use in hostile environments, including, without limitation, aircraft, nuclear power generation, medical appliances, and devices or systems in which malfunction of any Product can reasonably be expected to result in a personal injury. Seller's customers using or selling Seller's products for use in such applications do so at their own risk and agree to fully defend and indemnify Seller.